





TEST REPORT

No. I19Z61859-EMC02

for

TCL Communication Ltd.

USB Connect 4G V2 (NA)

Model Name: IK41US

FCC ID: 2ACCJB115

with

Hardware Version: V3.0

Software Version: IK41 ZZ 02.00 01

Issued Date: 2019-11-28

Note:

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Test Laboratory:

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REPORT HISTORY

Report Number Revision		Description	Issue Date	
I19Z61859-EMC02	Rev.0	1 st edition	2019-11-28	

Note: the latest revision of the test report supersedes all previous version.





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1. Test Laboratory

1.1. Introduction & Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2005 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (CN0066). The detail accreditation scope can be found on NVLAP website.

2. Test Laboratory

2.1. Testing Location

CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China100191

2.2. Testing Environment

Normal Temperature: $15-35^{\circ}$ C Relative Humidity: 20-75%

2.3. Project data

Testing Start Date: 2019-11-10
Testing End Date: 2019-11-28

2.4. Signature

Wang Junqing

(Prepared this test report)

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Zhang Ying

(Reviewed this test report)

Liu Baodian

Deputy Director of the laboratory

(Approved this test report)





3. Client Information

3.1. Applicant Information

Company Name: TCL Communication Ltd.

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Contact Person: Gong Zhizhou

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3.2. Manufacturer Information

Company Name: TCL Communication Ltd.

Address /Post: 5/F, Building 22E, 22 Science Park East Avenue, Hong Kong Science

Park, Shatin, NT, Hong Kong

Contact Person: Gong Zhizhou

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4. Equipment Under Test (EUT) and Ancillary Equipment (AE)

4.1. About EUT

Description USB Connect 4G V2 (NA)

Model Name IK41US FCC ID 2ACCJB115

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL,Telecommunication Technology Labs, CAICT.

4.2. Internal Identification of EUT used during the test

 EUT ID*
 SN or IMEI
 HW Version
 SW Version

 EUT1
 352540110000360
 V3.0
 IK41_ZZ_02.00_01

4.3. Internal Identification of AE used during the test

mer miterial identification of 712 deed during the teet				
AE ID*	Description	SN	Remarks	
AE1	Test Computer	/	/	
AE2	USB Cable	/	DC21a/22a	
AE2				
Model		/		
Manufac	turer	/		
Length o	of cable	/		
*^ []	used to identify the te	del edt al elamon to	internally.	

^{*}AE ID: is used to identify the test sample in the lab internally.

Note: The USB cables are shielded.

4.4. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.1	EUT1+ AE1	PC USB
Set.2	EUT1+ AE1 + AE2	OTG USB

Note: USB Connect 4G V2 (NA) IK41US is a variant model based on IK41VE for conformance test. According to the declaration of changes, no tests is performed. All results are inherited from the initial model. The report number of initial model is I19Z61810-EMC02.

^{*}EUT ID: is used to identify the test sample in the lab internally.





5. Reference Documents

5.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 15, Subpart B	Radio frequency devices - Unintentional Radiators	2016
ANSI C63.4	American National Standard for	2014
	Methods of Measurement of Radio-	
	Noise Emissions from Low-Voltage	
	Electrical and Electronic Equipment	
	in the Range of 9 kHz to 40 GHz	

Note: The test methods have no deviation with standards.





6. LABORATORY ENVIRONMENT

Semi-anechoic chamber SAC-1 (23 meters \times 17meters \times 10meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C	
Relative humidity	Min. = 15 %, Max. = 75 %	
Shielding effectiveness	0.014MHz-1MHz, >60dB;	
	1MHz - 1000MHz, >90dB.	
Electrical insulation	> 2 MΩ	
Ground system resistance	< 4 Ω	
Normalised site attenuation (NSA)	< ±4 dB, 10 m distance	
Site voltage standing-wave ratio (S _{VSWR})	Between 0 and 6 dB, from 1GHz to 6GHz	
Uniformity of field strength	Between 0 and 6 dB, from 80 to 3000 MHz	

Shielded room did not exceed following limits along the EMC testing:

	9
Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB;
	1MHz-1000MHz, >90dB.
Electrical insulation	> 2 MΩ
Ground system resistance	<4 Ω





7. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:		
	Р	Pass
Verdict Column	NA	Not applicable
	F	Fail

Items	Test Name	Clause in FCC rules	Section in this report	Verdict	Test Location
1	Radiated Emission	15.109(a)	B.1	Р	CTTL(huayuan North Road)
2	Conducted Emission	15.107(a)	B.2	Р	CTTL(huayuan North Road)





8. Test Equipments Utilized

NO.	Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE	CALIBRATI ON INTERVAL
1	Test Receiver	ESU26	100235	R&S	2020-03-01	1 Year
2	Test Receiver	ESCI3	100344	R&S	2020-02-14	1 Year
3	Universal Radio Communication Tester	CMW500	150344	R&S	2019-12-27	1 year
4	Universal Radio Communication Tester	CMW500	116588	R&S	2019-12-26	1 year
5	LISN	ENV216	101200	R&S	2020-03-14	1 year
6	EMI Antenna	VULB 9163	9163-1222	Schwarzbeck	2020-03-14	1 year
7	EMI Antenna	3115	6914	ETS-Lindgren	2020-01-03	1 year
8	PC	M4000E-17	M706GWXD	LENOVO	N/A	N/A
9	Printer	P1606dn	VNC3L52122	HP	N/A	N/A





ANNEX A: MEASUREMENT RESULTS

A.1 Radiated Emission

Reference

FCC: CFR Part 15.109(a).

A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator (USB mode of MS) at distances of 10 meters(for 30MHz-1GHz) and 3 meters (for above 1GHz) is tested. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 8.3.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3/10 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

A.1.2 EUT Operating Mode

The MS is operating in the USB mode. During the test MS is connected to a PC via a USB cable in the case of USB mode. The model of the PC is M4000E-17, and the serial number of the PC is M706GWXD. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.1.3 Measurement Limit

Frequency range	Field strength limit (μV/m)			
(MHz)	Quasi-peak Average		Peak	
30-88	100			
88-216	150			
216-960	200			
960-1000	500			
>1000		500	5000	

Note: the above limit is for 3 meters test distance. 10 meters' limit is got by converting.

A.1.4 Test Condition

Frequency range (MHz)	RBW/VBW	Sweep Time (s)	Detector
30-1000	120kHz (IF Bandwidth)	5	Peak/Quasi-peak
Above 1000	1MHz/1MHz	15	Peak, Average





A.1.5 Measurement Results

A "reference path loss" is established and the A_{Rpl} is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

Result = $P_{Mea} + A_{Rpl} = P_{Mea} + G_A + G_{PL}$

Where

G_A: Antenna factor of receive antenna

G_{PL}: Path Loss

 $P_{\mbox{\scriptsize Mea}}\mbox{:}$ Measurement result on receiver.

Measurement uncertainty (worst case): U = 5.44 dB, k=2.

Measurement results for Set.1:

USB Mode/Average detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna
Frequency (MHz)	Result	loss	Factor	Reading	Pol.
(IVITZ)	(dBµV/m)	(dB)	(dB/m)	(dBµV)	(H/V)
17951.833	46.5	-5.4	33.8	18.1	Н
17954.100	46.4	-5.4	33.8	18.0	Н
17952.967	46.4	-5.4	33.8	18.0	V
17950.133	46.4	-5.4	33.8	18.0	Н
17821.500	46.3	-5.7	33.8	18.2	Н
17941.633	46.3	-5.4	33.8	17.9	Н

USB Mode/ Peak detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna
Frequency	Result	loss	Factor	Reading	Pol.
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)
17843.600	58.1	-5.7	33.8	30.0	Н
17990.367	57.9	-5.4	33.8	29.5	Н
17975.633	57.9	-5.4	33.8	29.5	V
17402.167	57.8	-5.9	33.8	29.9	Н
17802.233	57.6	-5.7	33.8	29.5	Н
17917.267	57.6	-5.4	33.8	29.2	Н





Measurement results for Set.2:

USB Mode with OTG Cable/Average detector

Fraguency	Measurement	ement Cable Antenna		Receiver	Antenna
Frequency (MHz)	Result	loss	Factor	Reading	Pol.
(IVITZ)	(dBµV/m)	(dB)	(dB/m)	(dBµV)	(H/V)
17958.633	46.8	-17.7	45.6	18.9	Н
17826.033	46.7	-18.5	45.6	19.6	Н
17823.767	46.7	-18.5	45.6	19.6	V
17955.800	46.6	-17.7	45.6	18.7	Н
17960.333	46.5	-17.7	45.6	18.6	Н
17911.033	46.5	-18.5	45.6	19.4	Н

USB Mode with OTG Cable/ Peak detector

Fraguency	Measurement	Cable Antenn		Receiver	Antenna
Frequency (MHz)	Result	loss	Factor	Reading	Pol.
(IVITIZ)	(dBµV/m)	(dB)	(dB/m)	(dBµV)	(H/V)
17949.000	58.9	-17.7	45.6	31.0	Н
17513.800	58.3	-19.2	45.6	31.9	Н
17958.633	58.3	-17.7	45.6	30.4	V
17944.467	58.1	-17.7	45.6	30.2	Н
17930.300	58.0	-17.7	45.6	30.1	Н
17980.167	58.0	-17.7	45.6	30.1	Н





USB Mode, Set.1

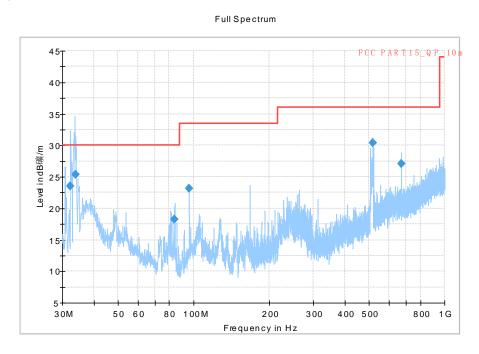


Fig A.1 Radiated Emission from 30MHz to 1GHz

Final_Result

Frequency	QuasiPeak	Limit	Margin	Meas.	Bandwidth	Height	Pol	Azimuth
(MHz)	(dBuV/m)	(dBuV/m)	(dB)	Time	(kHz)	(cm)		(deg)
				(ms)				
32.231000	23.58	30.00	6.42	1000.0	120.000	317.0	٧	282.0
33.746000	25.41	30.00	4.59	1000.0	120.000	217.0	٧	-30.0
84.066000	18.27	30.00	11.73	1000.0	120.000	307.0	٧	79.0
96.080000	23.22	33.50	10.30	1000.0	120.000	100.0	V	73.0
518.880000	30.44	36.00	5.58	1000.0	120.000	225.0	V	-20.0
671.983000	27.14	36.00	8.88	1000.0	120.000	225.0	٧	210.0





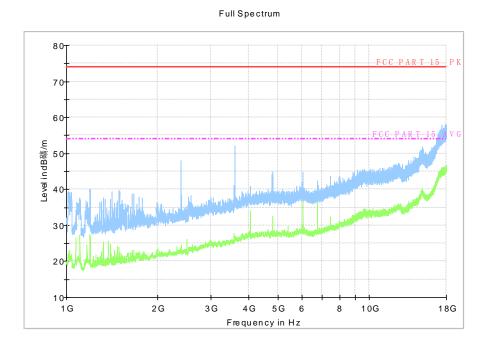


Fig A.2 Radiated Emission from 1GHz to 18GHz





USB Mode with OTG Cable, Set.2

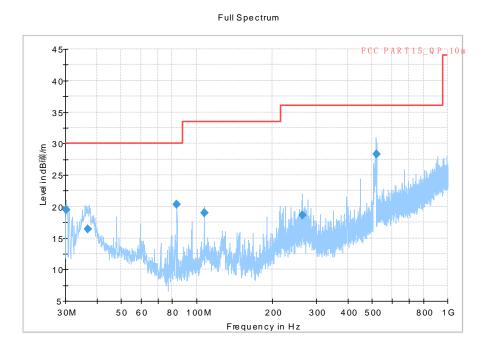


Fig A.3 Radiated Emission from 30MHz to 1GHz

Final_Result

Frequency	QuasiPeak	Limit	Margin	Meas.	Bandwidth	Height	Pol	Azimuth
(MHz)	(dBuV/m)	(dBuV/m)	(dB)	Time	(kHz)	(cm)		(deg)
				(ms)				
30.300000	19.51	30.00	10.49	1000.0	120.000	185.0	٧	241.0
36.795000	16.35	30.00	13.65	1000.0	120.000	125.0	٧	158.0
83.433000	20.35	30.00	9.65	1000.0	120.000	125.0	٧	19.0
107.235000	18.99	33.50	14.53	1000.0	120.000	116.0	٧	19.0
264.024000	18.63	36.00	17.39	1000.0	120.000	117.0	٧	20.0
519.360000	28.28	36.00	7.74	1000.0	120.000	278.0	٧	-12.0





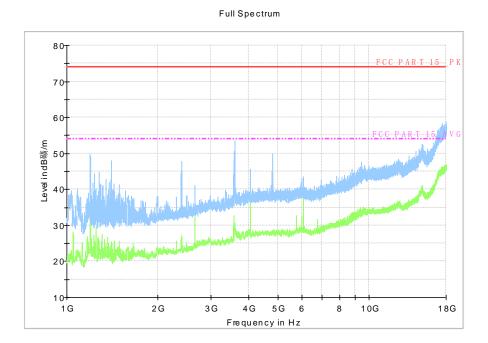


Fig A.4 Radiated Emission from 1GHz to 18GHz





A.2 Conducted Emission

Reference

FCC: CFR Part 15.107(a).

A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 7.3.

A.2.2 EUT Operating Mode

The MS is operating in the USB mode. During the test MS is connected to a PC via a USB cable in the case of USB mode. The model of the PC is DELL M4000E-17, and the serial number of the PC is M706GWXD. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBµV)					
	Quasi-peak	Average				
0.15-0.5	66 to 56*	56 to 46*				
0.5-5	56	46				
5-30	60	50				
*Decreases with the logarithm of the frequency						

A.2.4 Test Condition in charging mode

Voltage (V)	Frequency (Hz)
120	60

RBW/IF bandwidth	Sweep Time(s)
9kHz	1





A.2.5 Measurement Results

Measurement uncertainty: U= 3.38 dB, k=2.

USB Mode, Set.1

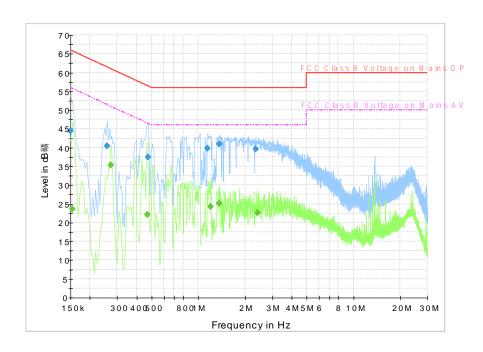


Fig A.5 Conducted Emission from 150kHz to 30MHz

Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit	Comment
(MHz)	(dBuV)	Time	(kHz)			(dB)	(dB)	(dBuV)	
		(ms)							
0.150000	44.4	2000.0	9.000	On	N	30.6	21.6	66.0	
0.258000	40.4	2000.0	9.000	On	N	19.8	21.1	61.5	
0.474000	37.5	2000.0	9.000	On	L1	19.8	18.9	56.4	
1.149000	39.8	2000.0	9.000	On	N	19.7	16.2	56.0	
1.369500	40.9	2000.0	9.000	On	L1	19.6	15.1	56.0	· · · · · · · · · · · · · · · · · · ·
2.337000	39.6	2000.0	9.000	On	N	19.6	16.4	56.0	

Final Result 2

Frequency	Average	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit	Comment
(MHz)	(dBuV)	Time	(kHz)			(dB)	(dB)	(dBuV)	
		(ms)							
0.154500	23.7	2000.0	9.000	On	L1	29.7	32.1	55.8	
0.271500	35.3	2000.0	9.000	On	L1	19.8	15.8	51.1	
0.469500	22.2	2000.0	9.000	On	L1	19.8	24.3	46.5	
1.203000	24.3	2000.0	9.000	On	L1	19.7	21.7	46.0	
1.369500	25.1	2000.0	9.000	On	L1	19.6	20.9	46.0	
2.409000	22.6	2000.0	9.000	On	L1	19.6	23.4	46.0	





USB Mode with OTG Cable, Set.2

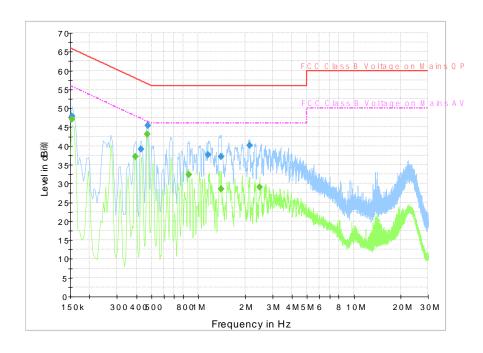


Fig A.6 Conducted Emission from 150kHz to 30MHz

Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit	Comment
(MHz)	(dBuV)	Time	(kHz)			(dB)	(dB)	(dBuV)	
		(ms)							
0.154500	47.8	1000.0	9.000	On	L1	29.7	17.9	65.8	
0.429000	39.1	1000.0	9.000	On	N	19.8	18.2	57.3	
0.474000	45.4	1000.0	9.000	On	N	19.8	11.1	56.4	
1.153500	37.6	1000.0	9.000	On	L1	19.7	18.4	56.0	
1.405500	37.1	1000.0	9.000	On	N	19.6	18.9	56.0	
2.134500	40.1	1000.0	9.000	On	N	19.6	15.9	56.0	

Final Result 2

Frequency	Average	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit	Comment
(MHz)	(dBuV)	Time	(kHz)			(dB)	(dB)	(dBuV)	
		(ms)							
0.154500	47.1	1000.0	9.000	On	L1	29.7	8.7	55.8	
0.393000	37.2	1000.0	9.000	On	L1	19.8	10.8	48.0	
0.469500	43.0	1000.0	9.000	On	L1	19.8	3.5	46.5	
0.865500	32.4	1000.0	9.000	On	N	19.7	13.6	46.0	
1.405500	28.5	1000.0	9.000	On	N	19.6	17.5	46.0	
2.485500	29.1	1000.0	9.000	On	N	19.6	16.9	46.0	





ANNEX B: PERSONS INVOLVED IN THIS TESTING

Test Item	Test Software and Version	Software Vendor	Test operator	
Conducted Emission	EMC32 V8.5.2	R&S	Shi Suolan	
Radiated Emission	EMC32 V9.01.00	R&S	Yan Hanchen Li Pengfei	

END OF REPORT